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	Subclass
Class	
ISSUE CLASSIFICATION	

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PATENT NUMBER

U.S. UTILITY Patent Application

JC2
809

O.I.P.E
SCANNED Q.A.

PATENT DATE

APPLICATION NO.	CONT/PRIOR	CLASS	SUBCLASS	ART UNIT	EXAMINER
09/752837	F	714	38	2184 2114	BEAUSOLIEL

APPLICANTS

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TITLE

Information processing apparatus, defect analysis program, defect analysis method, and application program development assistance system

PTO-2040
12/99

ISSUING CLASSIFICATION

ORIGINAL		CROSS REFERENCE(S)					
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				

INTERNATIONAL CLASSIFICATION

☐ Continued on Issue Slip Inside File Jacket

TERMINAL DISCLAIMER	DRAWINGS			CLAIMS ALLOWED	
	Sheets Drwg.	Figs. Drwg.	Print Fig.	Total Claims	Print Claim for O.G.

☐ The term of this patent subsequent to _____ (date) has been disclaimed.

6.5

(Assistant Examiner)   (Date)

NOTICE OF ALLOWANCE MAILED

☐ The term of this patent shall not extend beyond the expiration date of U.S Patent. No. _____

ISSUE FEE

Amount Due	Date Paid

(Primary Examiner)   (Date)

☐ The terminal _____ months of this patent have been disclaimed.

ISSUE BATCH NUMBER

(Legal Instruments Examiner)   (Date)

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